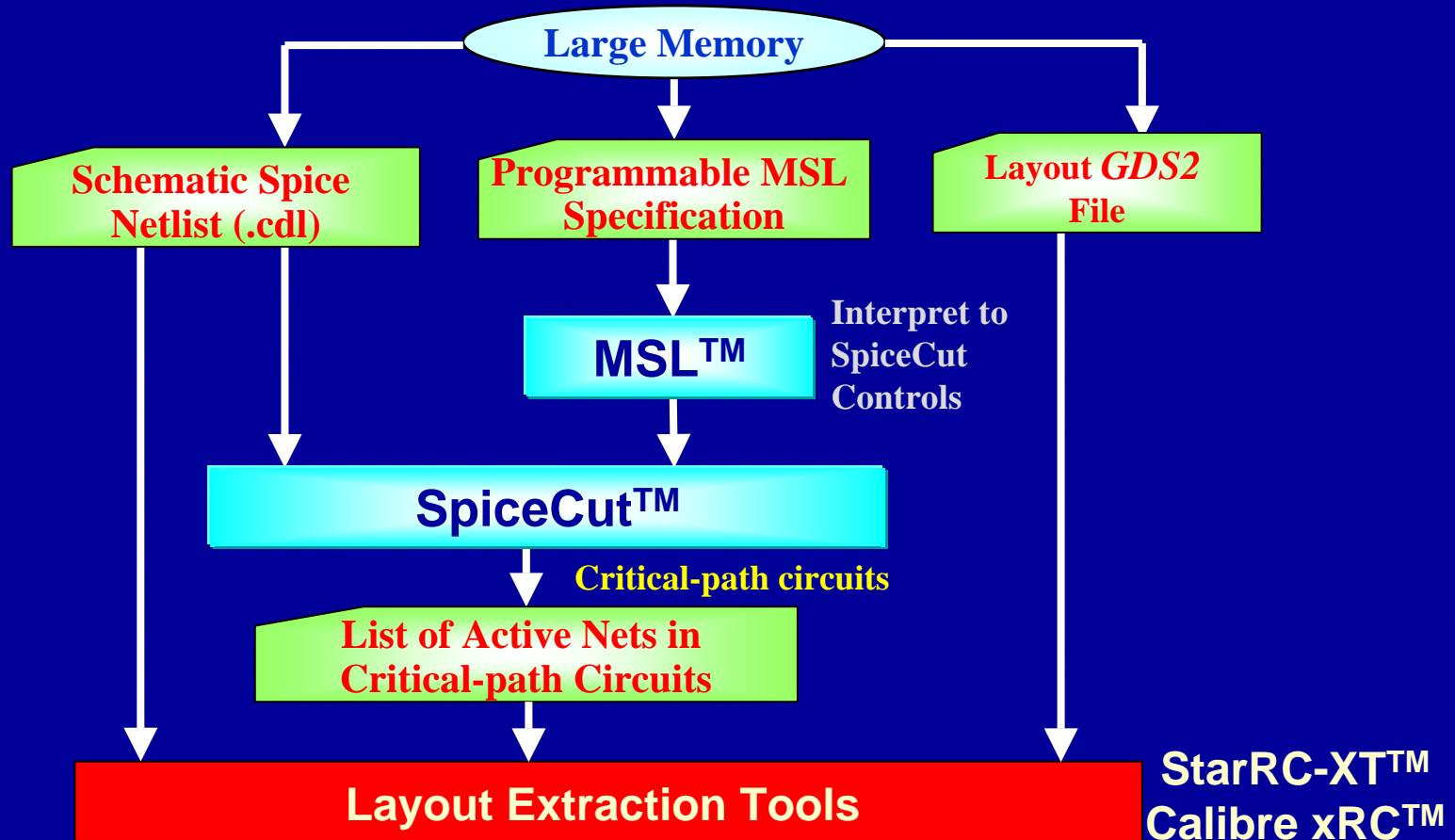


Large-Memory Characterization I

Layout RC-Extraction Only on Active Nets



Large-Memory Characterization II

Based on Circuit with RC Only on Active Nets

